

Notice of References Cited

Application/Control No.

10/530,515

Applicant(s)/Patent Under
Reexamination
SUNAGAWA ET AL.

Examiner

MICHAEL M. BERNSHTEYN

Art Unit

1796

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,854,346	12-1998	Meyer et al.	525/64
*	B	US-5,321,056	06-1994	Carson et al.	523/201
	C	US-			
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	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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